

**Search Notes**

Application/Control No.

10/630,243

Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	825.69	5/25/2005	NN
340	825.79	5/25/2005	NN
340	5.2+	5/25/2005	NN
340	5.7+	5/25/2005	NN
341	50	5/25/2005	NN
341	176	5/25/2005	NN
348	734	5/25/2005	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUBS; EPO; JPO and Derwent.	5/25/2005	NN